

Search Notes

Application/Control No.

10/654,770

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

PARK ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	694	5/4/2005	Bt
438	696	5/4/2005	bt
438	697	5/4/2005	bt
438	700	5/4/2005	bt
438	710	5/4/2005	BT
438	718	5/4/2005	BS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords and inventors' name using EAST	5/4/2005	BT

INTERFERENCE SEARCHED

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